

<b>Search Notes</b> 				<b>Application/Control No.</b> 10/598,762 <b>Examiner</b> Daniel St.Cyr	<b>Applicant(s)/Patent under Reexamination</b> ONISHI ET AL. <b>Art Unit</b> 2876
<b>SEARCHED</b>				<b>SEARCH NOTES (INCLUDING SEARCH STRATEGY)</b>	
Class	Subclass	Date	Examiner		DATE
235	486 489 490 487	9/16/2009	DS	EAST	9/16/2009
Updated	Search	11/22/2009	DS		
<b>INTERFERENCE SEARCHED</b>					
Class	Subclass	Date	Examiner		
same as	Above	11/22/2009	DS		